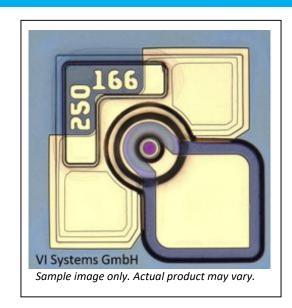


56 Gbit/s VCSEL (850 nm)
Contact type: GS/SG

Product Code:

VM50-850-C1 1x1 VM50-850-C4 4x1 VM50-850-C12 12x1



Product Description

These compact and very high modulation rate top-emitting GaAs-based vertical cavity surface emitting laser (VCSEL) chips and 1xN (N=4,12) arrays are available as engineering samples for use in the development and evaluation of optical interconnections, optical backplanes and integrated waveguides, and next-generation optical data communications systems. The VCSELs are contacted on the top-surface individually using ground-source (GS) microprobes, wire bonds, or flip-chip bonds.

Optical aperture: ~5-7µm

Features

- · 4-ch or 12 chip arrays
- · Up to 56 Gbit/s per channel
- · Device-to-device pitch of 250 µm
- · Suitable for wire or flip-chip bonding

Applications

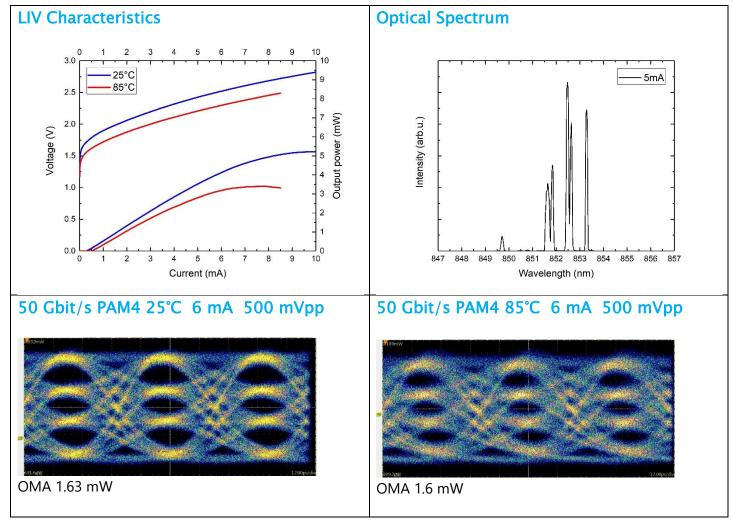
- · Ethernet
- · Proprietary optical interconnects
- · Active Optical Cables (AOC)
- · Short-reach 56G and 100G Ethernet

Parameter	Typical	Notes
Emission wavelength	850 nm	
Data rate	~56 Gbit/s	PAM-4
Threshold current	~ 0.5 mA	
Peak output power	~3 mW @85°C	



Electro-Optical Specifications (T = 0 to 85°C)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Emission wavelength	λ		840		860	nm
Maximum data rate	BR			25	28	GBaud/s
Optical bandwidth	BW (f3dBo)			18	20	GHz
Slope efficiency	η	5 mA	0.3		0.5	W/A
Threshold current	lth	25-85°C			0.8	mA
Differential resistance	Rd	5 mA		80	100	Ω
Beam divergence	Θ	FWHM		20		٥
Peak output power	Pmax			3	5	mW
Spectral bandwidth (RMS)	$\Delta \lambda_{RMS}$	5 mA		0.6	0.8	nm

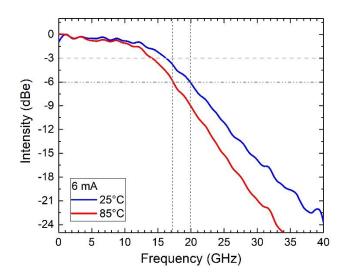


Transmitter: SHF BPG 12104A. Receiver: Tektronix DSA8300 w. 80C15 Optical Sampling Module.

Eye diagrams show intrinsic performance of the chip. No equalization or signal processing was applied.



Frequency response (electrical)





Absolute Maximum Ratings

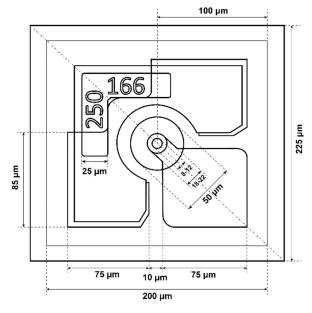
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Peak forward current	If				9	mA
Maximum reverse voltage	V_{rv}				5	V
Operating temperature	T _{op}				85	°C
Storage temperature	T_{st}		-40		100	°C
Soldering temperature	T _{sl}	max 260 sec			150	°C

Stress in excess of any of the individual Absolute Maximum Ratings can cause immediate irreversible damage to the component even if all other parameters are within the electro-optical specifications. Exposure to any of the Absolute Maximum Ratings for extended periods can adversely affect the reliability of these chips.

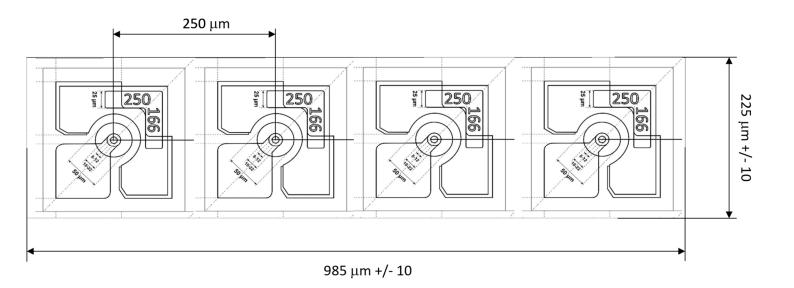
Mechanical Dimensions

Parameter	Туре	Min	Тур	Max	Unit
VCSEL pitch	All		250		μm
Length 1x1 VCSEL chip	VM50-850-C1		215	250	μm
Length 1x4 VCSEL array	VM50-850-C4		975	1000	μm
Length 1x12 VCSEL array	VM50-850-C12		2960	3000	μm
Height	All	140	150	160	μm
Width	All		210	250	μm

Dimensions



VM50-850-C4 Array dimensions

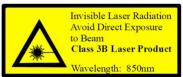


Qualification Notification

The VM50-850-Cxx has been qualified to meet the specifications outlined in this data. A reliability assessment report is available as a separate document. However, it has not undergone full qualification testing or characterization and therefore may not meet the performance specifications over all extremes. Preliminary reliability assessment can be provided upon request.







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